

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	6,296,908	10/02/2001	(Bel. to corresp. to DE Reihs et al	199,24,092) 427	393.5	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

**FOREIGN PATENT DOCUMENTS**

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							Yes	No*
	AL	2,308,900	11/26/2000	(Bel. to corresp. to DE 199,24,091) Canada				
	AM	11-60851	03/05/99	Japan (Abstract attached)				X
	AN							
	AO							
	AP							

**OTHER PRIOR ART** (Including Author, Title, Date, Pertinent Pages, Etc.)

	AR		
	AS		
	AT		

EXAMINER

DATE CONSIDERED

EXAMINER Initial if referenced considered, whether or not citation is in conformance with MPEP 609: Draw line through if not in conformance and not considered. Include copy of this form with next communication to applicant.

\*

Neither English Language Equivalent nor an English Language Translation is available.